

**Notice of References Cited**

Application/Control No.

09/769,275

Applicant(s)/Patent Under  
Reexamination  
SCHERB ET AL.

Examiner

Mark Halpern

Art Unit

1731

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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	C	US-			
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	K	US-			
	L	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	DE 19756422	06-1999	Germany	Tietz, et al.	D21 F11/14
	O					
	P					
	Q					
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**NON-PATENT DOCUMENTS**

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